

Preliminary datasheet

EasyPACK™ module with CoolSiC™ Trench MOSFET and PressFIT / NTC

Features

- Electrical features
 - $V_{DSS} = 1200\text{ V}$
 - $I_{DN} = 63\text{ A} / I_{DRM} = 125\text{ A}$
 - Low switching losses
 - Low inductive design
- Mechanical features
 - PressFIT contact technology
 - AlN substrate with low thermal resistance
 - Integrated NTC temperature sensor
 - Rugged mounting due to integrated mounting clamps



Typical appearance

Potential applications

- High-frequency switching application
- Motor drives
- UPS systems
- DC/DC converter
- DC charger for EV

Product validation

- Qualified for industrial applications according to the relevant tests of IEC 60747, 60749 and 60068

Description

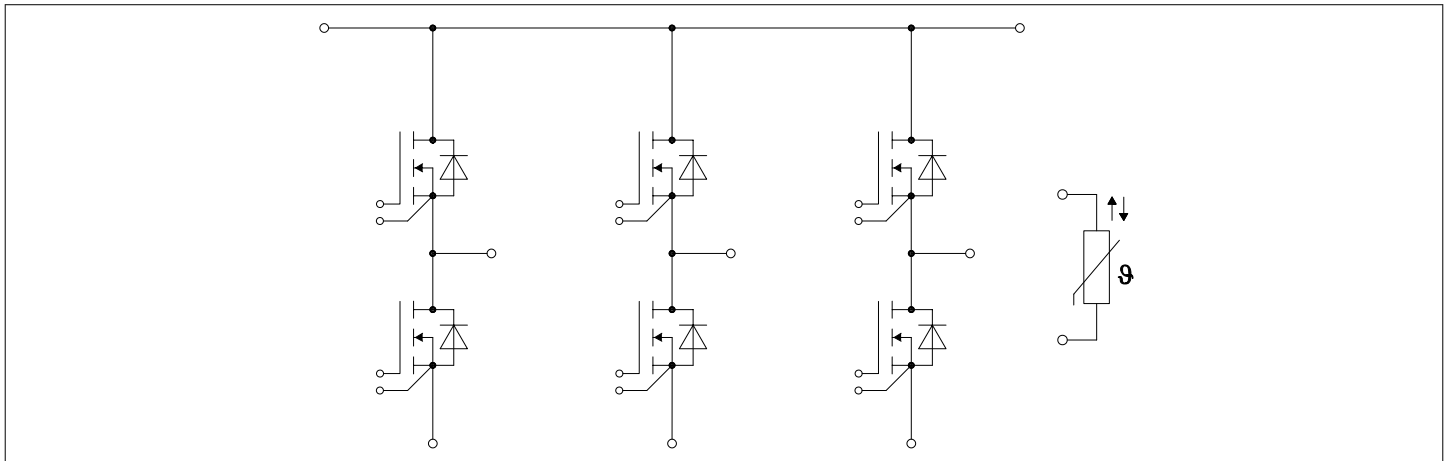


Table of contents

	Description	1
	Features	1
	Potential applications	1
	Product validation	1
	Table of contents	2
1	Package	3
2	MOSFET	3
3	Body diode (MOSFET)	5
4	NTC-Thermistor	6
5	Characteristics diagrams	7
6	Circuit diagram	12
7	Package outlines	13
8	Module label code	14
	Revision history	15
	Disclaimer	16

1 Package

Table 1 Insulation coordination

Parameter	Symbol	Note or test condition	Values	Unit
Isolation test voltage	V_{ISOL}	RMS, $f = 50 \text{ Hz}$, $t = 1 \text{ min}$	3.0	kV
Internal isolation		basic insulation (class 1, IEC 61140)	AIN	
Comparative tracking index	CTI		> 200	
Relative thermal index (electrical)	RTI	housing	140	°C

Table 2 Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Stray inductance module	L_{sCE}			13		nH
Module lead resistance, terminals - chip	$R_{CC'+EE'}$	$T_H = 25 \text{ °C}$, per switch		4.6		mΩ
Storage temperature	T_{stg}		-40		125	°C
Mounting force per clamp	F		40		80	N
Weight	G			39		g

Note: The current under continuous operation is limited to 25 A rms per connector pin.
 Functional isolation applies for the NTC inside module, detailed description refers to AN2009-10, chapter 2.1.
 A isolation test voltage of 1.5kV RMS, $f = 50\text{Hz}$, $t = 1\text{min}$ is applied between NTC and the other components inside module.

2 MOSFET

Table 3 Maximum rated values

Parameter	Symbol	Note or test condition	Values	Unit
Drain-source voltage	V_{DSS}	$T_{vj} = 25 \text{ °C}$	1200	V
Continuous DC drain current	I_{DDC}	$T_{vj} = 175 \text{ °C}$, $V_{GS} = 18 \text{ V}$ $T_H = 90 \text{ °C}$	62.5	A
Repetitive peak drain current	I_{DRM}	verified by design, t_p limited by T_{vjmax}	125	A
Gate-source voltage, max. transient voltage	V_{GS}	$D < 0.01$	-10/23	V
Gate-source voltage, max. static voltage	V_{GS}		-7/20	V

Table 4 Recommended values

Parameter	Symbol	Note or test condition	Values	Unit
On-state gate voltage	$V_{GS(on)}$		15...18	V
Off-state gate voltage	$V_{GS(off)}$		-5...0	V

Table 5 Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit	
			Min.	Typ.	Max.		
Drain-source on-resistance	$R_{DS(on)}$	$I_D = 62.5 \text{ A}$	$V_{GS} = 18 \text{ V}, T_{vj} = 25 \text{ }^\circ\text{C}$		11.7		mΩ
			$V_{GS} = 18 \text{ V}, T_{vj} = 125 \text{ }^\circ\text{C}$		18.9		
			$V_{GS} = 18 \text{ V}, T_{vj} = 150 \text{ }^\circ\text{C}$		21.7		
			$V_{GS} = 15 \text{ V}, T_{vj} = 25 \text{ }^\circ\text{C}$		14		
Gate threshold voltage	$V_{GS(th)}$	$I_D = 28 \text{ mA}, V_{DS} = V_{GS}, T_{vj} = 25 \text{ }^\circ\text{C},$ (tested after 1ms pulse at $V_{GS} = +20 \text{ V}$)	3.45	4.3	5.15	V	
Total gate charge	Q_G	$V_{DD} = 800 \text{ V}, V_{GS} = -3/18 \text{ V}$		0.2		μC	
Internal gate resistor	R_{Gint}	$T_{vj} = 25 \text{ }^\circ\text{C}$		7.5		Ω	
Input capacitance	C_{ISS}	$f = 100 \text{ kHz}, V_{DS} = 800 \text{ V}, V_{GS} = 0 \text{ V}, T_{vj} = 25 \text{ }^\circ\text{C}$		6.05		nF	
Output capacitance	C_{OSS}	$f = 100 \text{ kHz}, V_{DS} = 800 \text{ V}, V_{GS} = 0 \text{ V}, T_{vj} = 25 \text{ }^\circ\text{C}$		0.3		nF	
Reverse transfer capacitance	C_{RSS}	$f = 100 \text{ kHz}, V_{DS} = 800 \text{ V}, V_{GS} = 0 \text{ V}, T_{vj} = 25 \text{ }^\circ\text{C}$		0.02		nF	
C_{OSS} stored energy	E_{OSS}	$V_{DS} = 800 \text{ V}, V_{GS} = -3/18 \text{ V}, T_{vj} = 25 \text{ }^\circ\text{C}$		118		μJ	
Drain-source leakage current	I_{DSS}	$V_{DS} = 1200 \text{ V}, V_{GS} = -3 \text{ V}, T_{vj} = 25 \text{ }^\circ\text{C}$		0.04	111	μA	
Gate-source leakage current	I_{GSS}	$V_{DS} = 0 \text{ V}, T_{vj} = 25 \text{ }^\circ\text{C}$	$V_{GS} = 20 \text{ V}$		400	nA	
Turn-on delay time (inductive load)	$t_{d on}$	$I_D = 62.5 \text{ A}, R_{Gon} = 5.1 \text{ }^\circ\Omega, V_{DD} = 600 \text{ V}, V_{GS} = -3/18 \text{ V}$	$T_{vj} = 25 \text{ }^\circ\text{C}$		58		ns
			$T_{vj} = 125 \text{ }^\circ\text{C}$		58		
			$T_{vj} = 150 \text{ }^\circ\text{C}$		58		
Rise time (inductive load)	t_r	$I_D = 62.5 \text{ A}, R_{Gon} = 5.1 \text{ }^\circ\Omega, V_{DD} = 600 \text{ V}, V_{GS} = -3/18 \text{ V}$	$T_{vj} = 25 \text{ }^\circ\text{C}$		15		ns
			$T_{vj} = 125 \text{ }^\circ\text{C}$		15		
			$T_{vj} = 150 \text{ }^\circ\text{C}$		15		

(table continues...)

Table 5 (continued) Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Turn-off delay time (inductive load)	$t_{d\ off}$	$I_D = 62.5\ A, R_{Goff} = 5.1\ \Omega, V_{DD} = 600\ V, V_{GS} = -3/18\ V$	$T_{vj} = 25\ ^\circ C$	114		ns
			$T_{vj} = 125\ ^\circ C$	126		
			$T_{vj} = 150\ ^\circ C$	129		
Fall time (inductive load)	t_f	$I_D = 62.5\ A, R_{Goff} = 5.1\ \Omega, V_{DD} = 600\ V, V_{GS} = -3/18\ V$	$T_{vj} = 25\ ^\circ C$	34		ns
			$T_{vj} = 125\ ^\circ C$	36		
			$T_{vj} = 150\ ^\circ C$	37		
Turn-on energy loss per pulse	E_{on}	$I_D = 62.5\ A, V_{DD} = 600\ V, L_\sigma = 35\ nH, V_{GS} = -3/18\ V, R_{Gon} = 5.1\ \Omega, di/dt = 3.2\ kA/\mu s (T_{vj} = 150\ ^\circ C)$	$T_{vj} = 25\ ^\circ C$	1.39		mJ
			$T_{vj} = 125\ ^\circ C$	1.57		
			$T_{vj} = 150\ ^\circ C$	1.64		
Turn-off energy loss per pulse	E_{off}	$I_D = 62.5\ A, V_{DD} = 600\ V, L_\sigma = 35\ nH, V_{GS} = -3/18\ V, R_{Goff} = 5.1\ \Omega, dv/dt = 13\ kV/\mu s (T_{vj} = 150\ ^\circ C)$	$T_{vj} = 25\ ^\circ C$	1.06		mJ
			$T_{vj} = 125\ ^\circ C$	1.14		
			$T_{vj} = 150\ ^\circ C$	1.15		
Thermal resistance, junction to heat sink	R_{thJH}	per MOSFET, $\lambda_{grease} = 1\ W/(m\cdot K)$		0.661		K/W
Temperature under switching conditions	$T_{vj\ op}$		-40		150	$^\circ C$

Note: The selection of positive and negative gate-source voltages impacts losses and the long-term behavior of the MOSFET and body diode. The design guidelines described in Application Note AN 2018-09 and AN 2021-13 must be considered to ensure sound operation of the device over the planned lifetime.

3 Body diode (MOSFET)

Table 6 Maximum rated values

Parameter	Symbol	Note or test condition	Values	Unit
DC body diode forward current	I_{SD}	$T_{vj} = 175\ ^\circ C, V_{GS} = -3\ V, T_H = 90\ ^\circ C$	30	A

Table 7 Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Forward voltage	V_{SD}	$I_{SD} = 62.5\ A, V_{GS} = -3\ V$	$T_{vj} = 25\ ^\circ C$	4.14	5.35	V
			$T_{vj} = 125\ ^\circ C$	3.88		
			$T_{vj} = 150\ ^\circ C$	3.82		

4 NTC-Thermistor

Table 8 Characteristic values

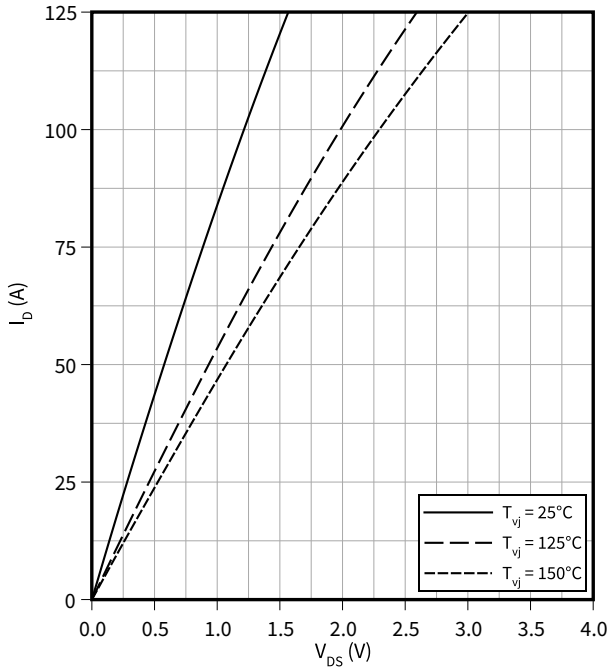
Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Rated resistance	R_{25}	$T_{NTC} = 25\text{ °C}$		5		kΩ
Deviation of R_{100}	$\Delta R/R$	$T_{NTC} = 100\text{ °C}, R_{100} = 493\ \Omega$	-5		5	%
Power dissipation	P_{25}	$T_{NTC} = 25\text{ °C}$			20	mW
B-value	$B_{25/50}$	$R_2 = R_{25} \exp[B_{25/50}(1/T_2 - 1/(298,15\text{ K}))]$		3375		K
B-value	$B_{25/80}$	$R_2 = R_{25} \exp[B_{25/80}(1/T_2 - 1/(298,15\text{ K}))]$		3411		K
B-value	$B_{25/100}$	$R_2 = R_{25} \exp[B_{25/100}(1/T_2 - 1/(298,15\text{ K}))]$		3433		K

Note: Specification according to the valid application note.

5 Characteristics diagrams

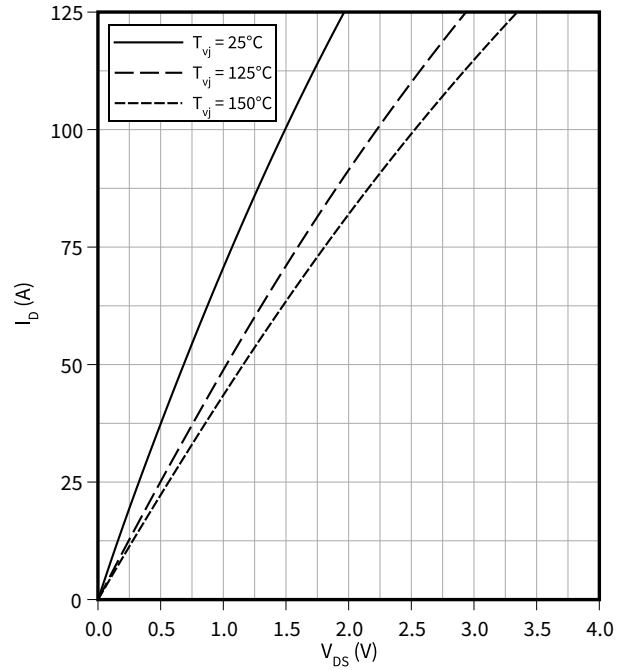
Output characteristic (typical), MOSFET

$I_D = f(V_{DS})$
 $V_{GS} = 18\text{ V}$



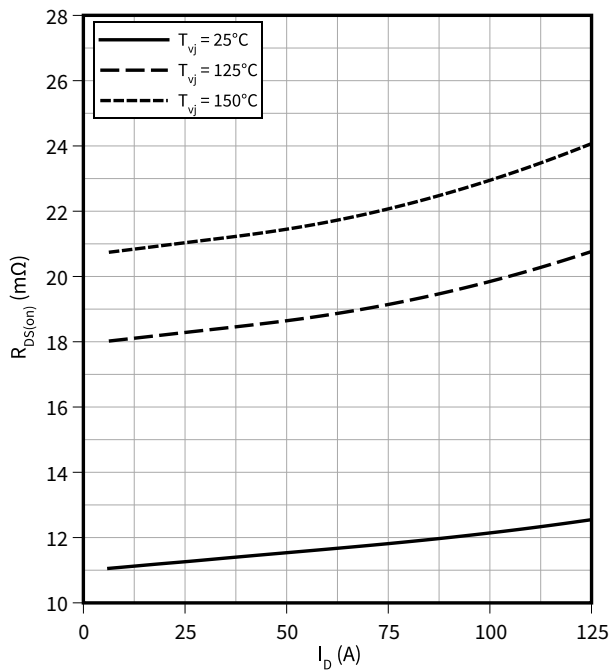
Output characteristic (typical), MOSFET

$I_D = f(V_{DS})$
 $V_{GS} = 15\text{ V}$



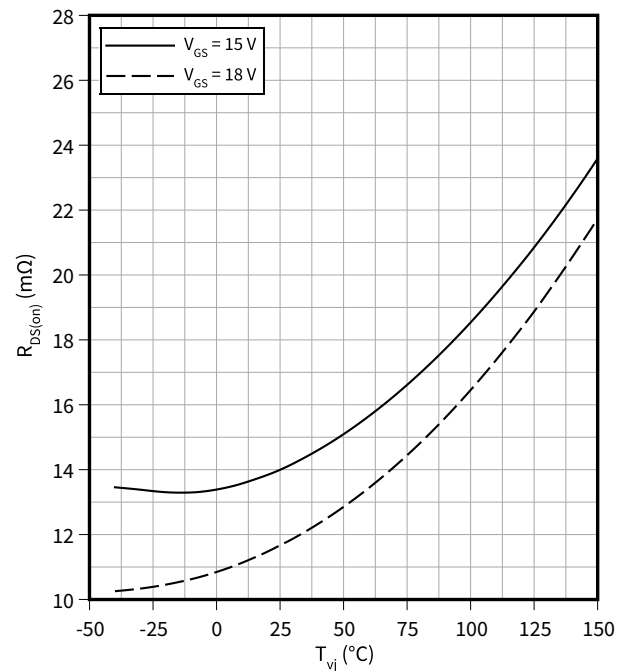
Drain source on-resistance (typical), MOSFET

$R_{DS(on)} = f(I_D)$
 $V_{GS} = 18\text{ V}$



Drain source on-resistance (typical), MOSFET

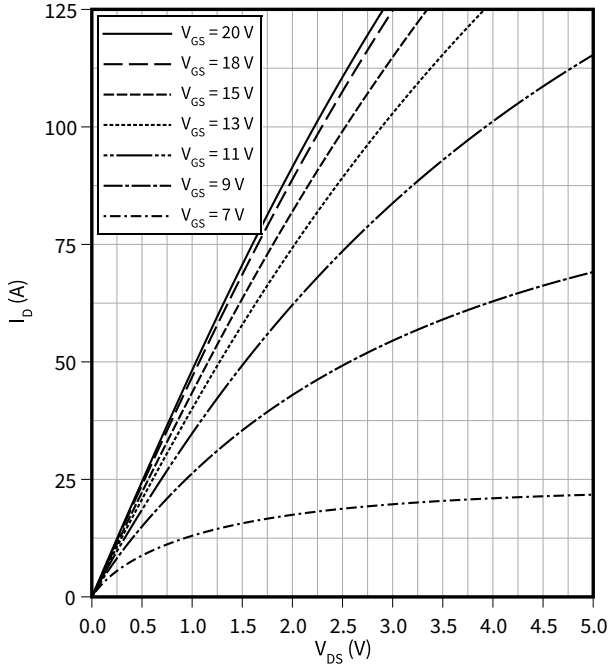
$R_{DS(on)} = f(T_{vj})$
 $I_D = 62.5\text{ A}$



5 Characteristics diagrams

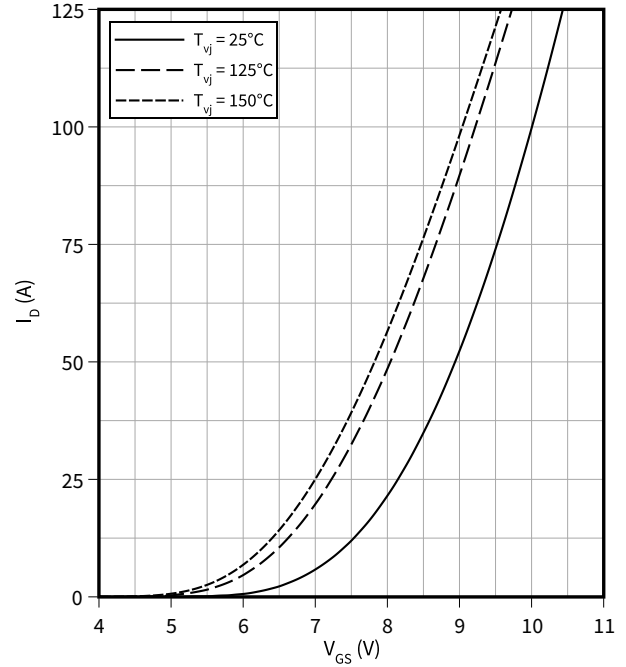
Output characteristic field (typical), MOSFET

$I_D = f(V_{DS})$
 $T_{vj} = 150\text{ °C}$



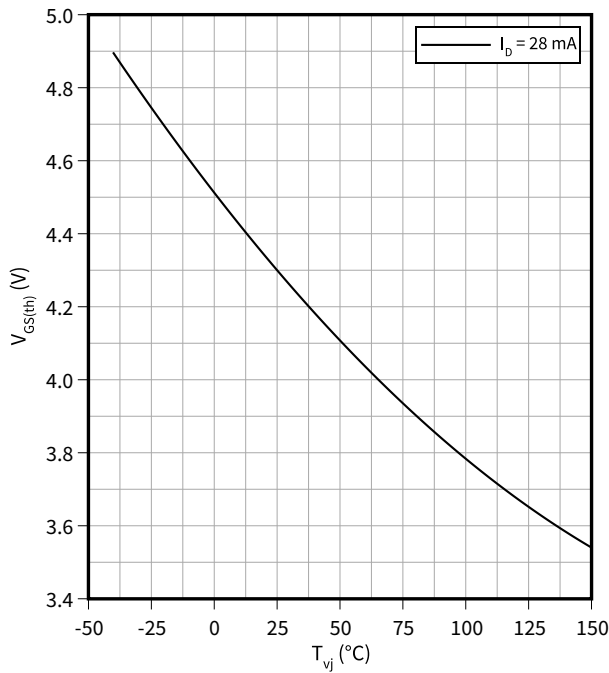
Transfer characteristic (typical), MOSFET

$I_D = f(V_{GS})$
 $V_{DS} = 20\text{ V}$



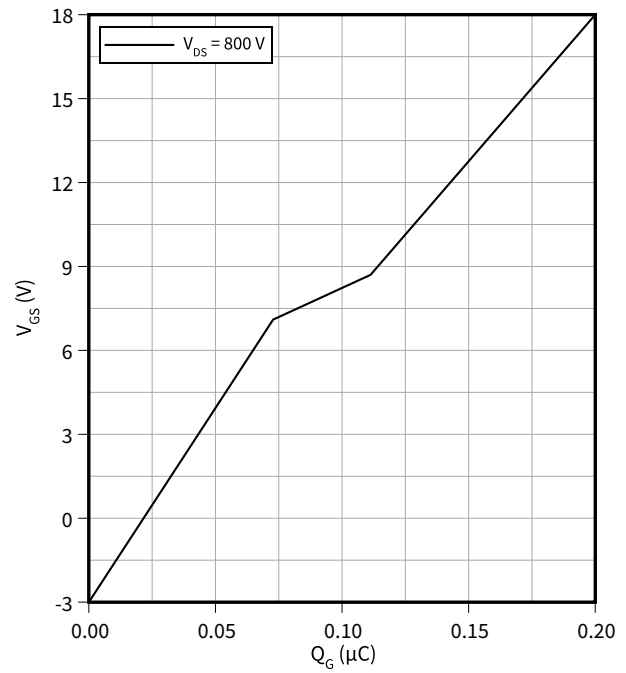
Gate-source threshold voltage (typical), MOSFET

$V_{GS(th)} = f(T_{vj})$
 $V_{GS} = V_{DS}$



Gate charge characteristic (typical), MOSFET

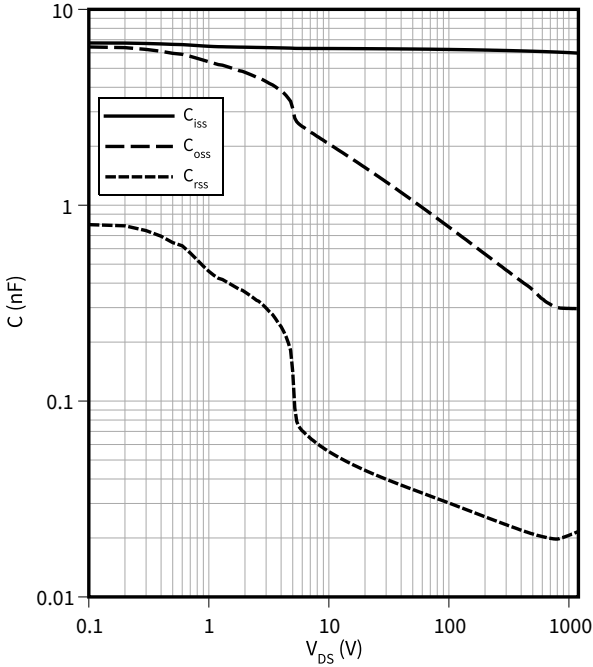
$V_{GS} = f(Q_G)$
 $I_D = 62.5\text{ A}, T_{vj} = 25\text{ °C}$



5 Characteristics diagrams

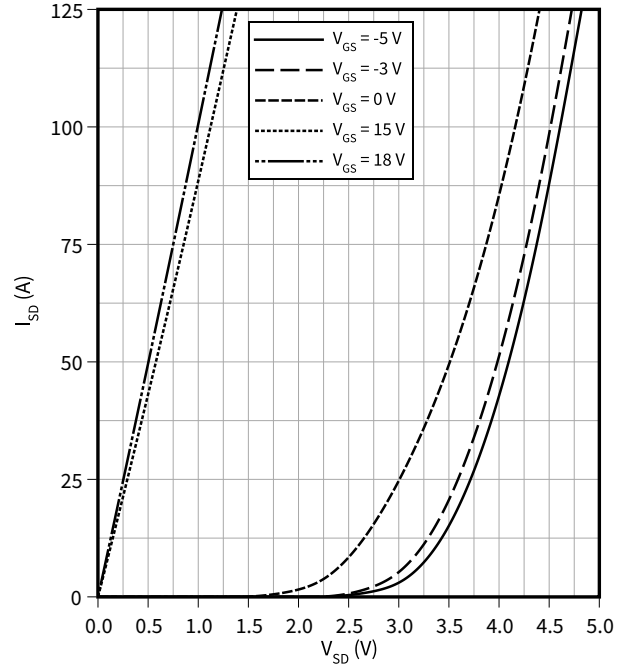
Capacity characteristic (typical), MOSFET

$C = f(V_{DS})$
 $f = 100 \text{ kHz}, T_{vj} = 25 \text{ }^\circ\text{C}, V_{GS} = 0 \text{ V}$



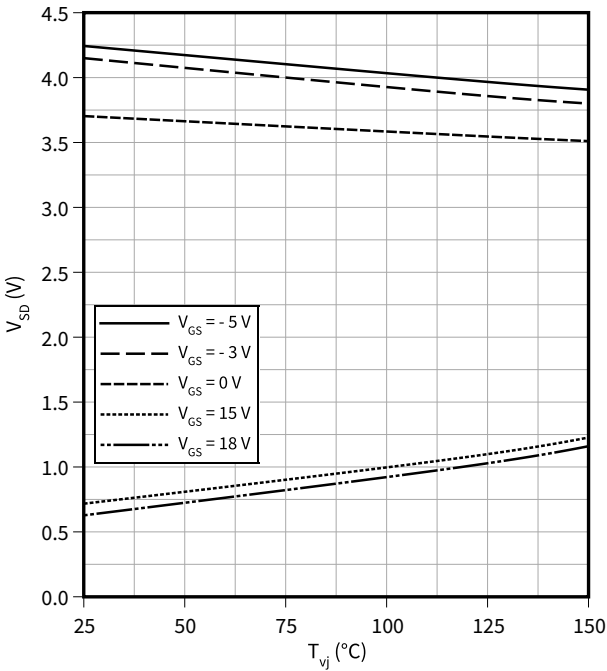
Forward characteristic body diode (typical), MOSFET

$I_{SD} = f(V_{SD})$
 $T_{vj} = 25 \text{ }^\circ\text{C}$



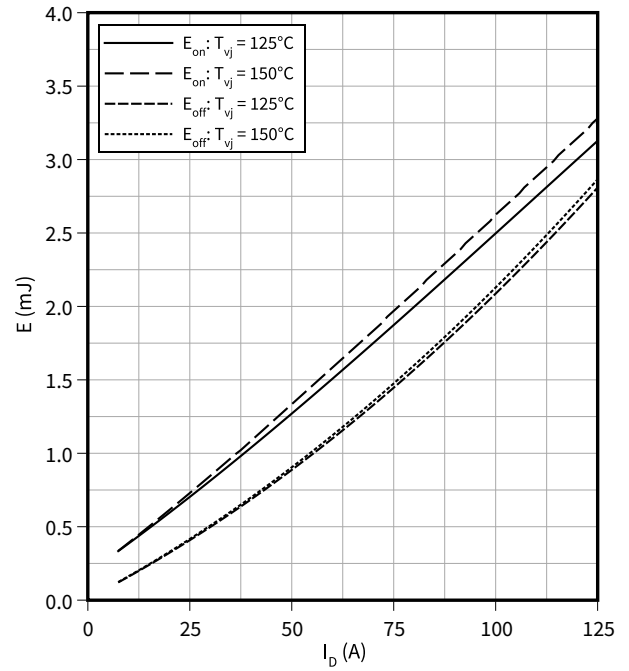
Forward voltage of body diode (typical), MOSFET

$V_{SD} = f(T_{vj})$
 $I_{SD} = 62.5 \text{ A}$



Switching losses (typical), MOSFET

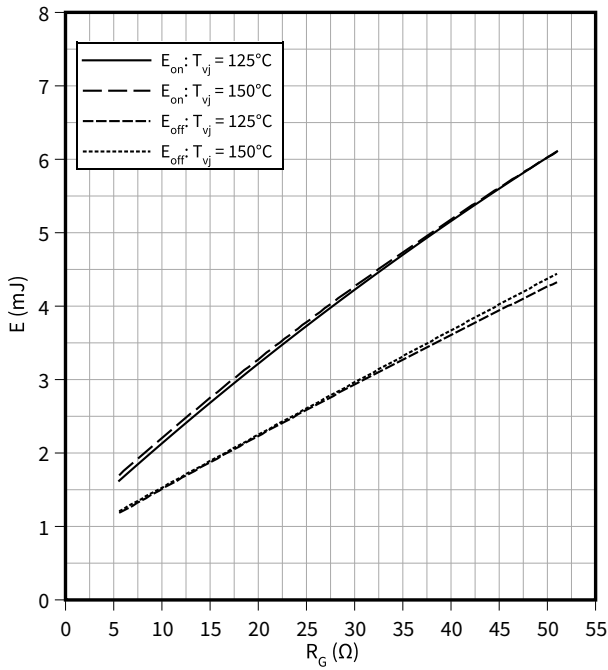
$E = f(I_D)$
 $R_{Goff} = 5.1 \text{ } \Omega, R_{Gon} = 5.1 \text{ } \Omega, V_{DD} = 600 \text{ V}, V_{GS} = -3/18 \text{ V}$



Switching losses (typical), MOSFET

$E = f(R_G)$

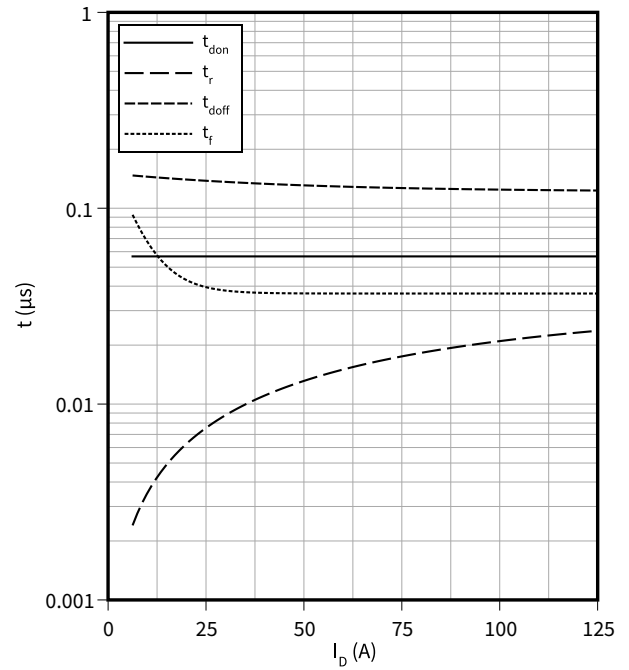
$V_{DD} = 600\text{ V}$, $I_D = 62.5\text{ A}$, $V_{GS} = -3/18\text{ V}$



Switching times (typical), MOSFET

$t = f(I_D)$

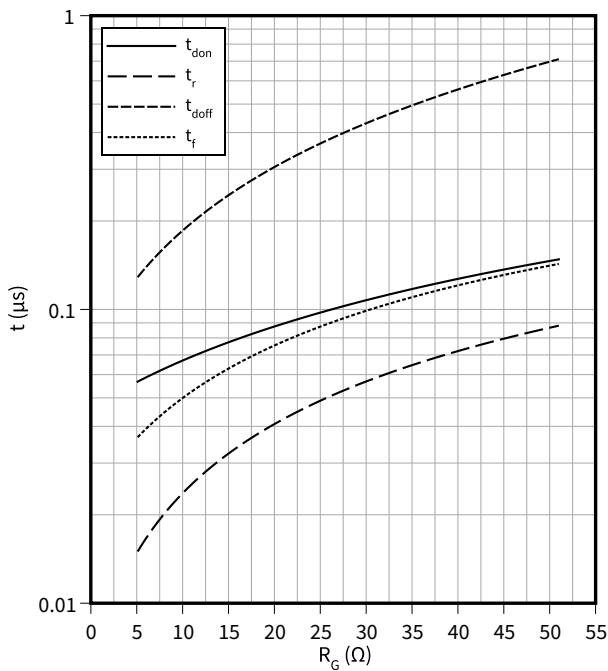
$R_{Goff} = 5.1\ \Omega$, $R_{Gon} = 5.1\ \Omega$, $V_{DD} = 600\text{ V}$, $T_{vj} = 150\text{ °C}$, $V_{GS} = -3/18\text{ V}$



Switching times (typical), MOSFET

$t = f(R_G)$

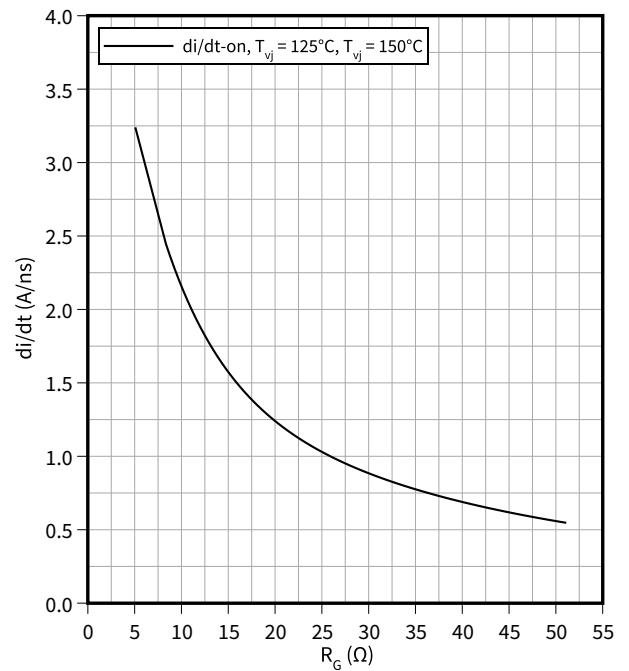
$V_{DD} = 600\text{ V}$, $I_D = 62.5\text{ A}$, $T_{vj} = 150\text{ °C}$, $V_{GS} = -3/18\text{ V}$



Current slope (typical), MOSFET

$di/dt = f(R_G)$

$V_{DD} = 600\text{ V}$, $I_D = 62.5\text{ A}$, $V_{GS} = -3/18\text{ V}$

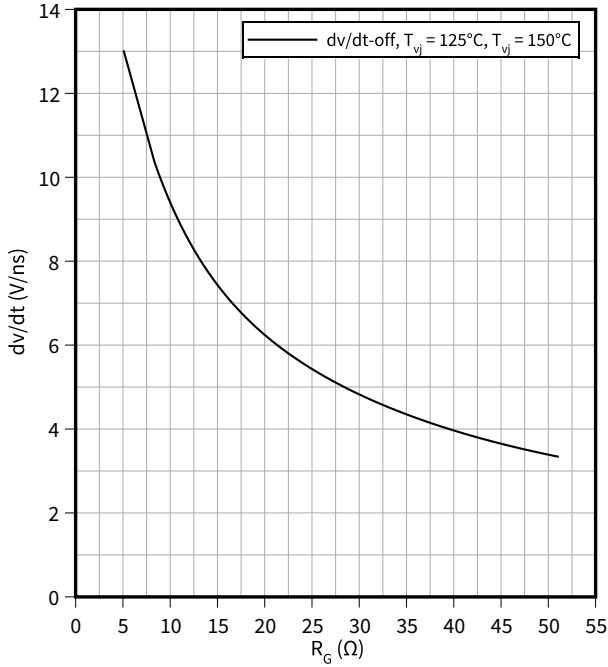


5 Characteristics diagrams

Voltage slope (typical), MOSFET

$dv/dt = f(R_G)$

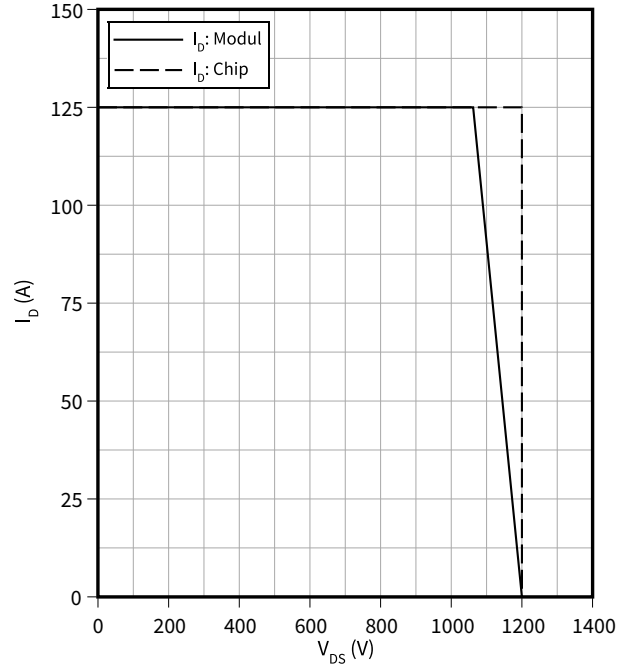
$V_{DD} = 600\text{ V}, I_D = 62.5\text{ A}, V_{GS} = -3/18\text{ V}$



Reverse bias safe operating area (RBSOA), MOSFET

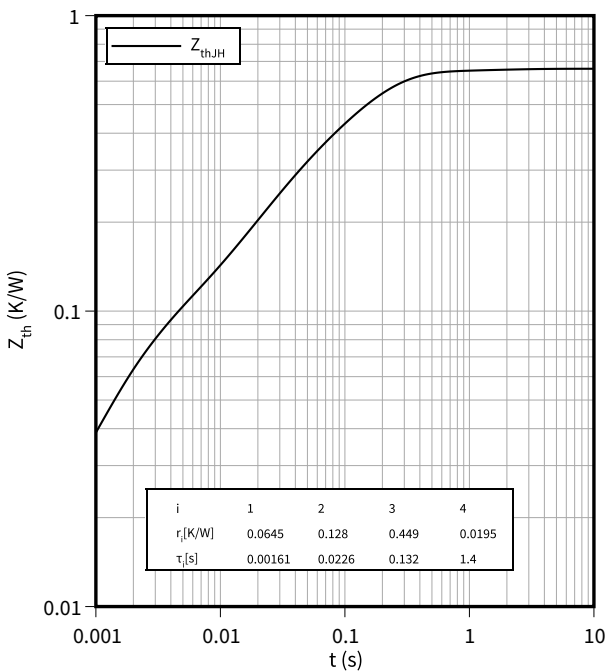
$I_D = f(V_{DS})$

$R_{Goff} = 5.1\ \Omega, T_{vj} = 150\ \text{°C}, V_{GS} = -3/18\ \text{V}$



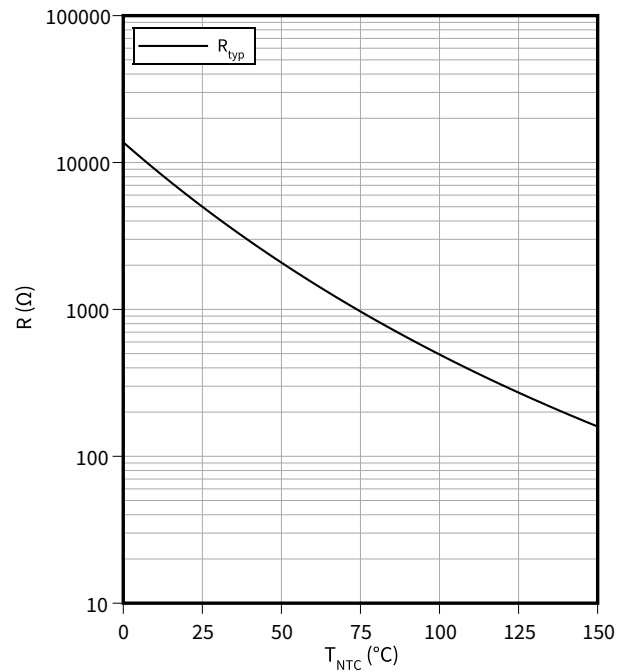
Transient thermal impedance, MOSFET

$Z_{th} = f(t)$



Temperature characteristic (typical), NTC-Thermistor

$R = f(T_{NTC})$



6 Circuit diagram

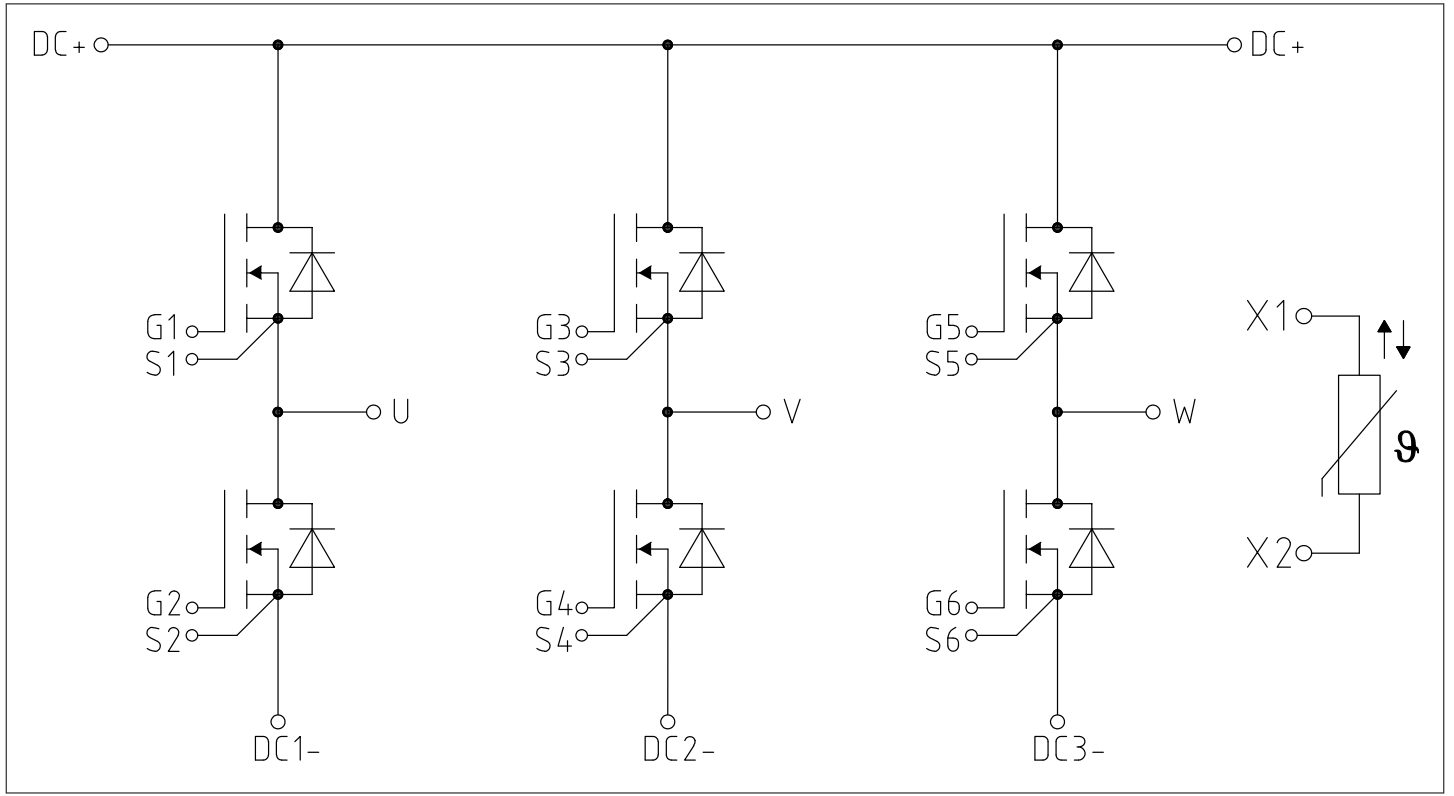


Figure 1

7 Package outlines

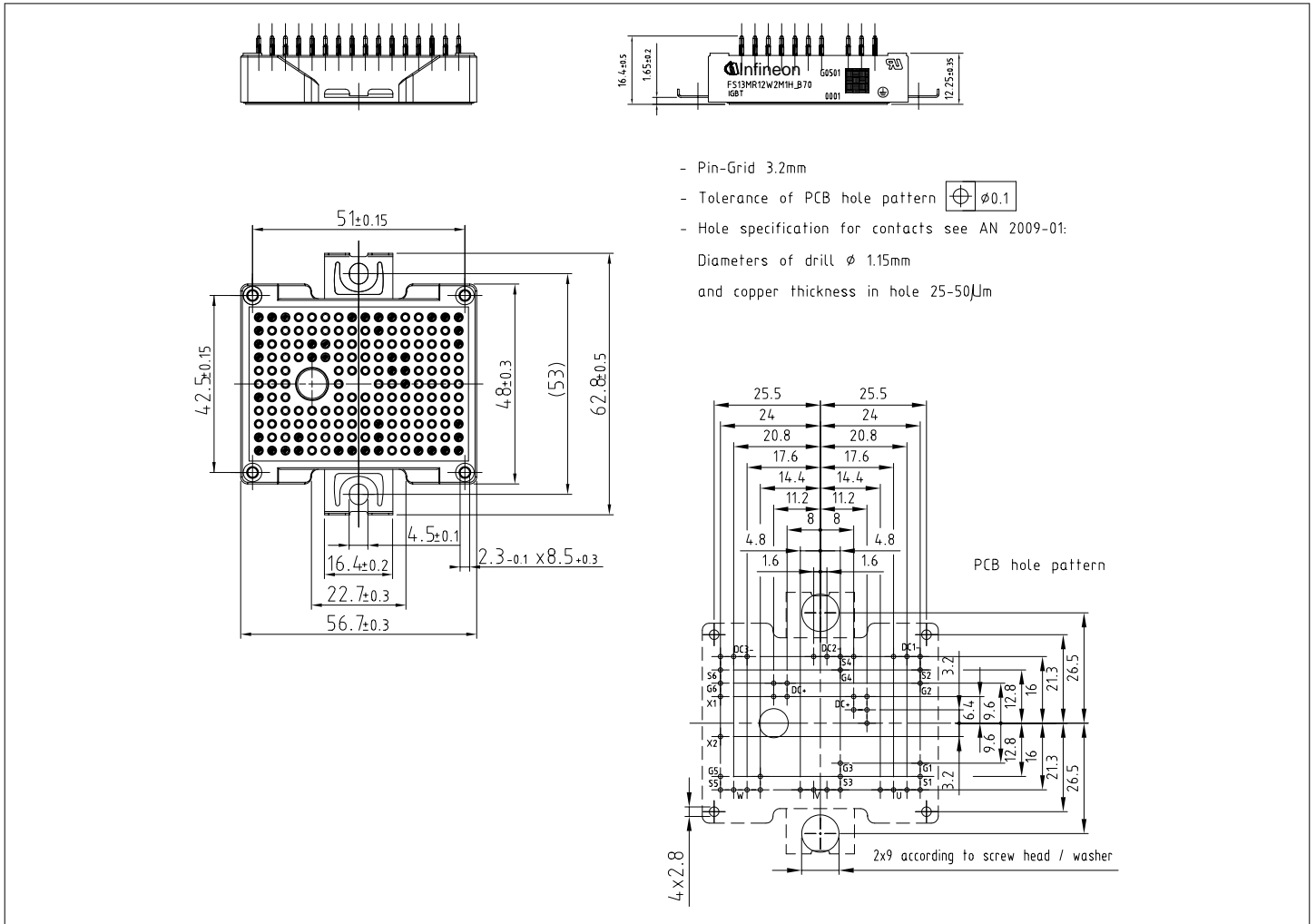


Figure 2

8 Module label code

Module label code			
Code format	Data Matrix	Barcode Code128	
Encoding	ASCII text	Code Set A	
Symbol size	16x16	23 digits	
Standard	IEC24720 and IEC16022	IEC8859-1	
Code content	<i>Content</i> Module serial number Module material number Production order number Date code (production year) Date code (production week)	<i>Digit</i> 1 - 5 6 - 11 12 - 19 20 - 21 22 - 23	<i>Example</i> 71549 142846 55054991 15 30
Example	 		
	71549142846550549911530		71549142846550549911530

Figure 3

Revision history

Document revision	Date of release	Description of changes
0.10	2022-03-18	Initial version
0.20	2022-06-14	Preliminary datasheet
0.30	2023-03-02	Preliminary datasheet